

Ministry of Foreign Affairs and International Cooperation

Mass testing of Large-PMT electronics at Kunshan for the JUNO experiment

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UNIVERSITÀ **DEGLI STUDI** DI PADOVA

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- DSNB: 2-4 IBD/year
- Solar v: O(100)/year
- Atmospheric v: O(100)/year
- Geo-v: ~400/year

 $u_{ au}$



 u_e

GCUs are the **key component** in the processing of Large-PMT signals: a thorough characterization during mass production is required.

Each channel is equipped with an internal test pulse generator, or **calibration circuit**. The circuit is used to check that the channel is **working** and to **calibrate** it.

The amplitude of the pulse is set with a 16-bit Digital to Analog Converter (**DAC**). The pulse is generated with the help of a **switch** which is controlled via IPbus [4].



Mass testing at production site in Kunshan, China



Main **physics goals**:

- > neutrino mass ordering determination @ 3σ in 6 years
- measurement of three oscillation parameters with sub-percent precision



Assembled Under Water Box (UWB)







Digitized **waveform** generated from the calibration circuit:



Test Protocol

1. Ping Test: check **connection** of the GCU to the network; send 100 56-Byte packtes in 1 seconds to each GCU

4. Slow control monitoring: quantities are read through the asynchronous link via **IPbus** protocol [4]; e.g.,

Waveform length and position of waveform can be changed online via **IPbus protocol** [4]. The current **window** for the waveform is 304 ns.

Waveform **properties** that we have to check:

- baseline
- noise
- trigger stability
- integrated charge
- packet size validity
 - timestamp vailidty



2. Linearity Test: calibrate each channel, evaluate gain for **High** Gain and **Low** Gain ADCs; short runs at various test pulse amplitude

3. Stability Test: check **stability** of parameter over time; e.g., baseline, baseline sigma, integrated charge; long run at fixed test pulse amplitude

- FPGA temperature
- HVU temperature
- PMT high voltage
- internal voltages and currents

5. DDR3: check storage capabilities and event loss rate



References: [1] JUNO Collaboration, JUNO Physics and Detector, 2021, arXiv:2104.02565 [2] JUNO Collaboration, *Neutrino Physics* with JUNO, J. Phys. G43, 3, 030401 (2016) [arXiv:1507.05613] [3] JUNO Collaboration, JUNO CDR, 2015, arXiv:1508.07166 (chapter 7) [4] C. Ghabrous Larrea et al., *IPbus: a* flexible Ethernet-based control system for xTCA hardware, JINST 10 (2015) no.02, C02019